

CEPC Fast Luminosity Detector design using SiC

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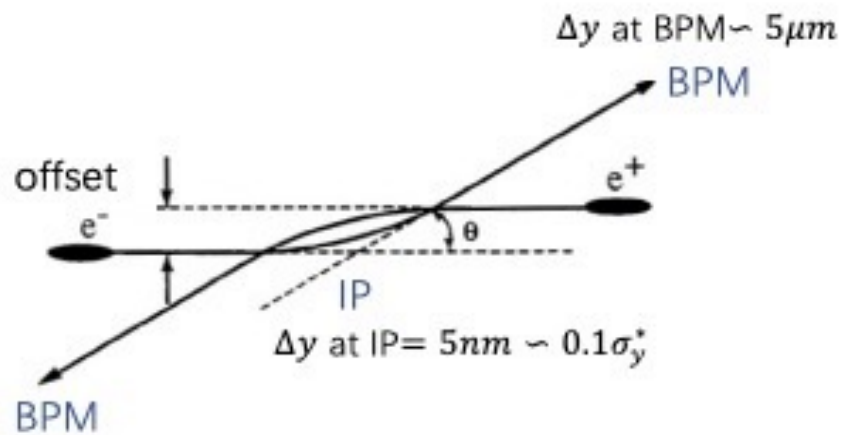
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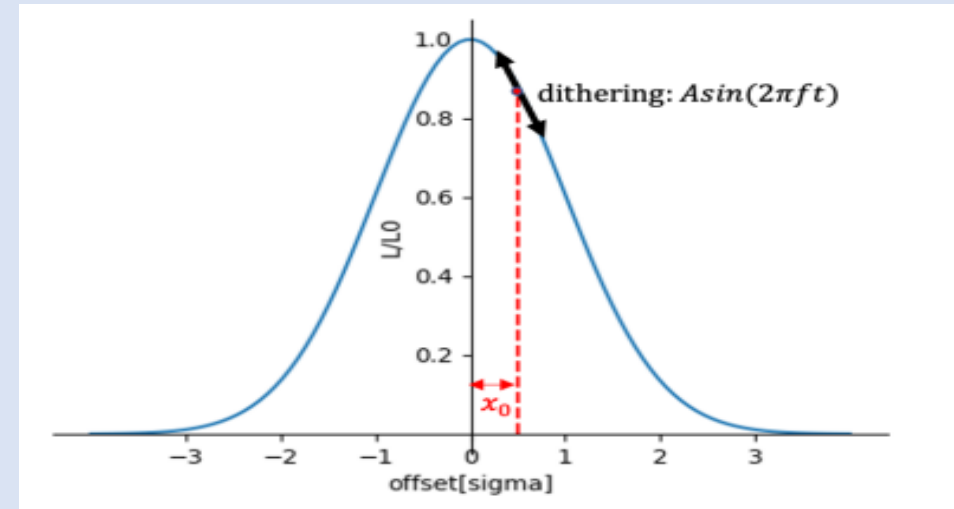
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- Crab waist scheme for CEPC to achieve a very high luminosity ($5 \times 10^{34} \text{ cm}^{-2}\text{s}^{-1}$)
 - IP beam size very small
 - Luminosity sensitive to the stability of beam jitter (like ground motion)
- Orbit feedback system at the IP to maintain an optimum collision and maximize the luminosity
- Two possible methods for the IP orbit feedback system

Vertical IP orbit feedback—**Beam-beam deflection driven method**

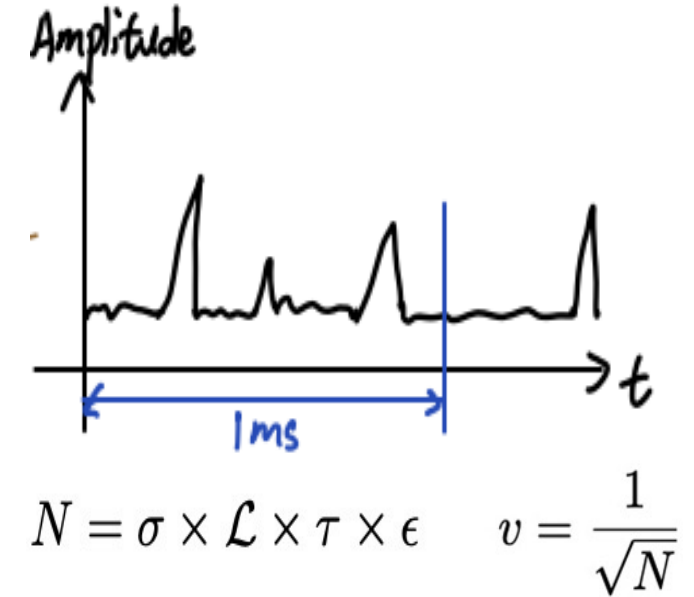
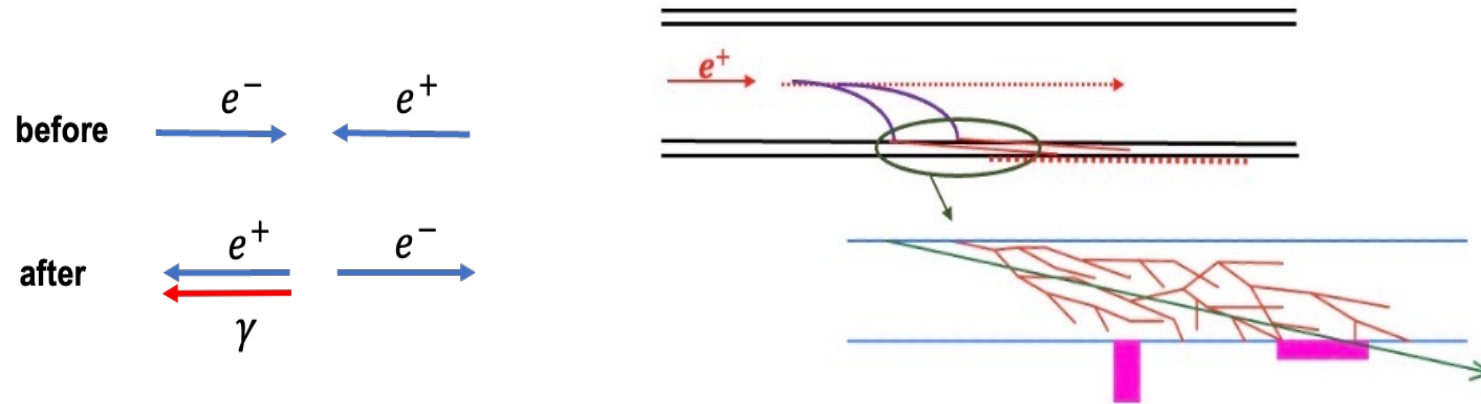


Horizontal IP orbit feedback—**Luminosity driven method**



- Insufficient BPM resolution in the horizontal plane, a luminosity-driven dithering feedback system required

- The fast luminosity monitor based on radiative Bhabha at zero degree
 - Very large cross section (127mbarn)
 - Bhabha particles produced at the IP are proportional to the luminosity



- The low energy Bhabha hit the vacuum chamber downstream of the IP
- The detectors put outside the beam pipe measuring the secondary particles to provide the luminosity information
 - Number of Bhabha sensitive to the change of luminosity in proportion way (relative luminosity measurement)

Luminosity	Cross section	Number of Bhabha	Aimed precision	Required fraction
5×10^{34}	0.127 barn	6.35×10^6 in 1ms	2% in 1ms	4×10^{-4}

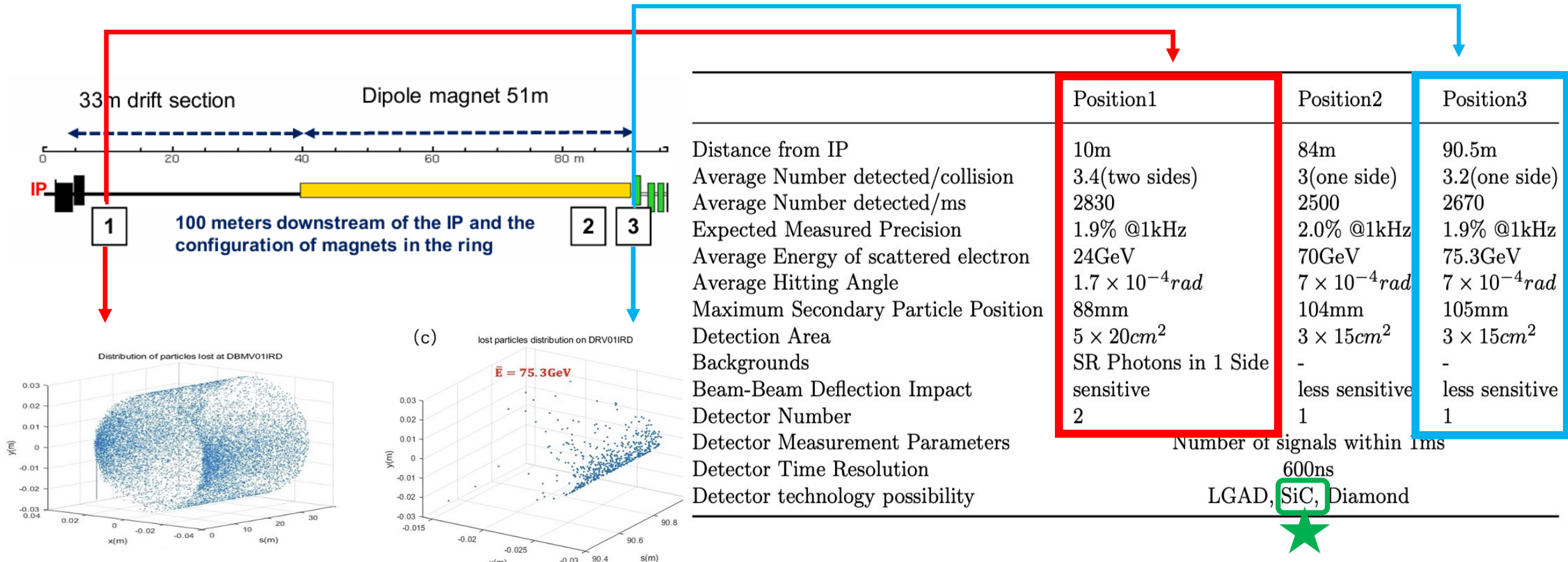
$$\Delta N = L \times \sigma \times T \times f \Rightarrow L \propto \Delta N$$

- Precision requirement: $v \leq 2\% @1\text{kHz}$ (Number of detected Bhabha electrons $N_d \geq 2500$)

The position of Fast Luminosity Monitor

Meng Li from accelerator

- Low-energy scattered electrons are mainly lost at Position 1、2 and 3
- Positions 1 and 3 : suitable for detector installation
- Position 2 excluded: not feasible for detector installation (inside the dipole magnet)



[DOI: <https://doi.org/10.1007/s41605-024-00491-8>]

Silicon carbide

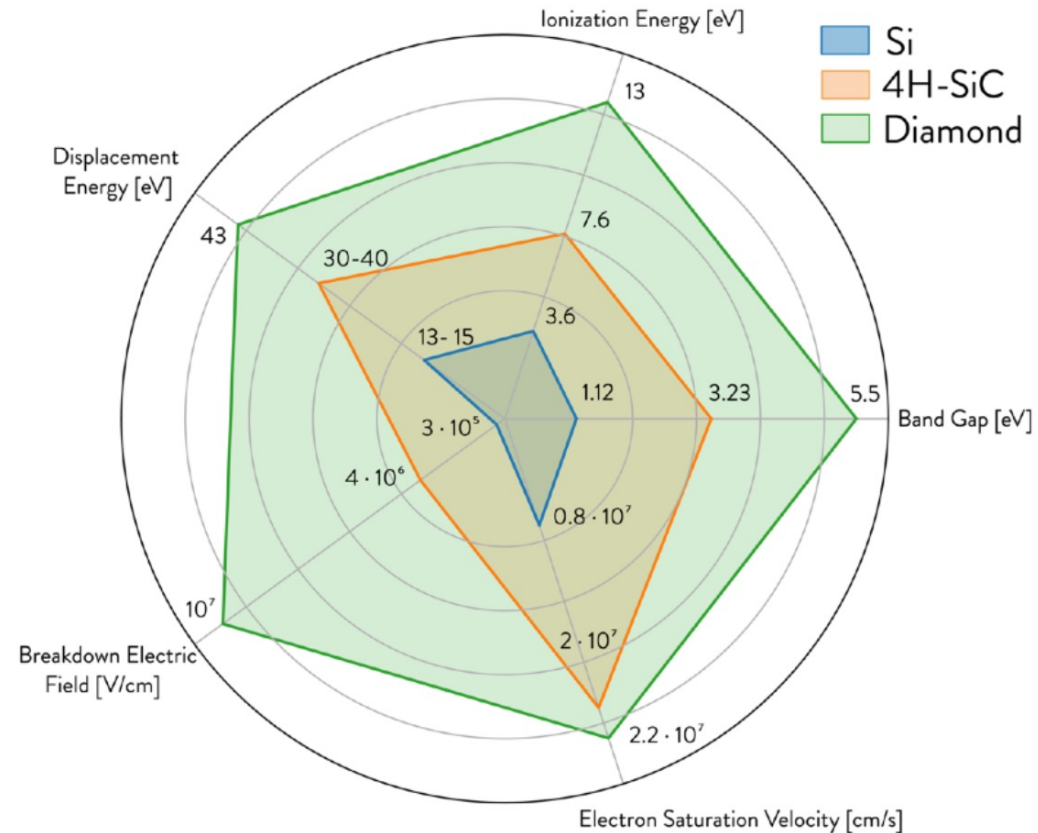
Wide band material Silicon Carbide(SiC) as particle detector material:

● Pros:

- Bandgap between silicon and diamond
- Higher saturation velocity and breakdown field
- Larger atomic displacement threshold
- Potentially good radiation hardness
- No dark current increase after irradiation
- High thermal conductivity
- No cooling needs
- No sensitivity to visible light

● Cons:

- Different polytypes(3C, 4H, 6H)
- Higher ionization energy
- Smaller signals → LGAD
- Epitaxial-grown limited to $\sim 150\mu\text{m}$ thickness



[Front. Phys., 2022]

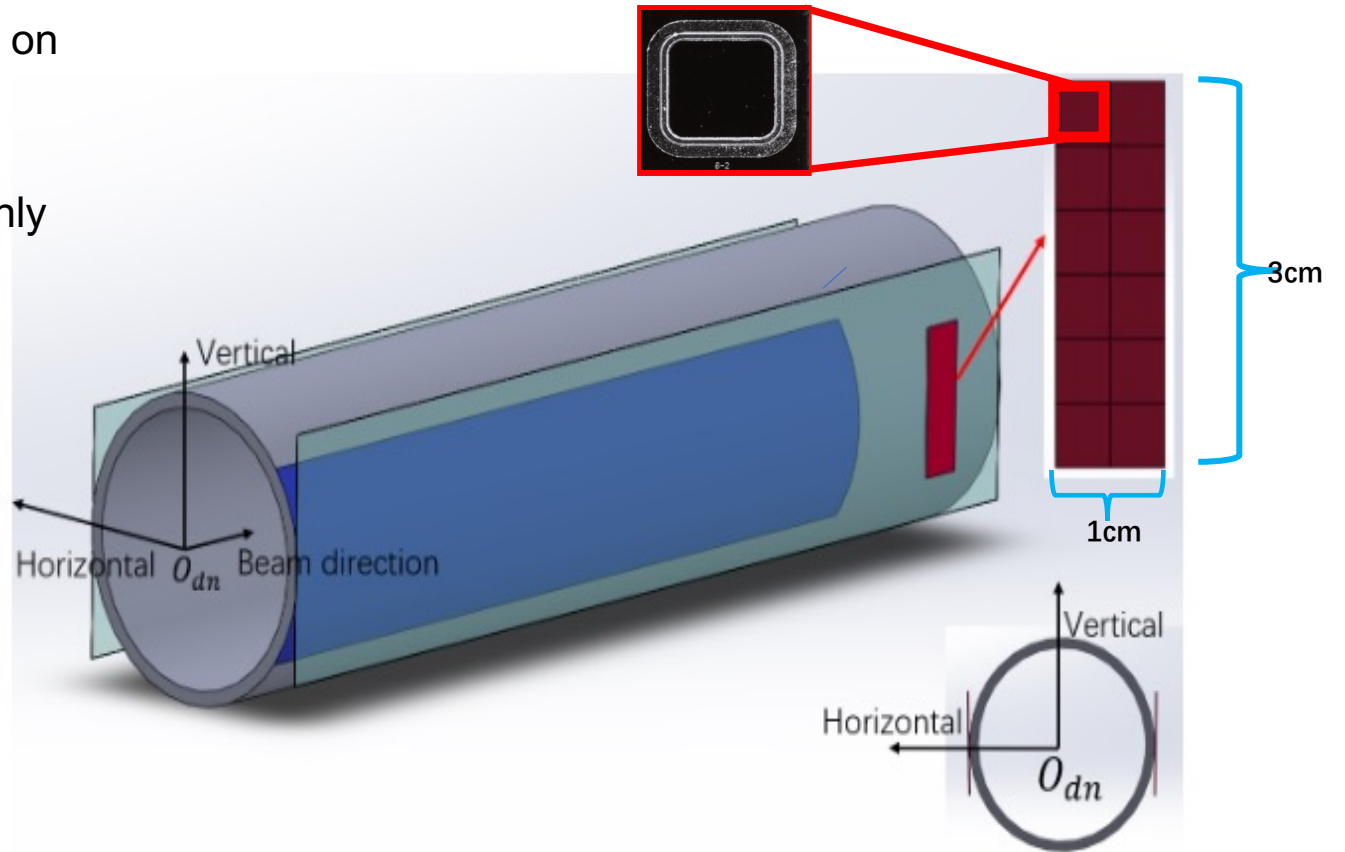
Detector Geometry & Layout Optimization

- Detector layout

- Position1: **double detectors** - symmetrically on inner and outer of beam pipe
- Position3: **single detector** – on outer side only

- Detector dimension :

- Total Size: 1 cm (beam) × 3 cm (vertical)
- 2 × 6 pixels
- Unit size: 5 mm × 5 mm per pixel



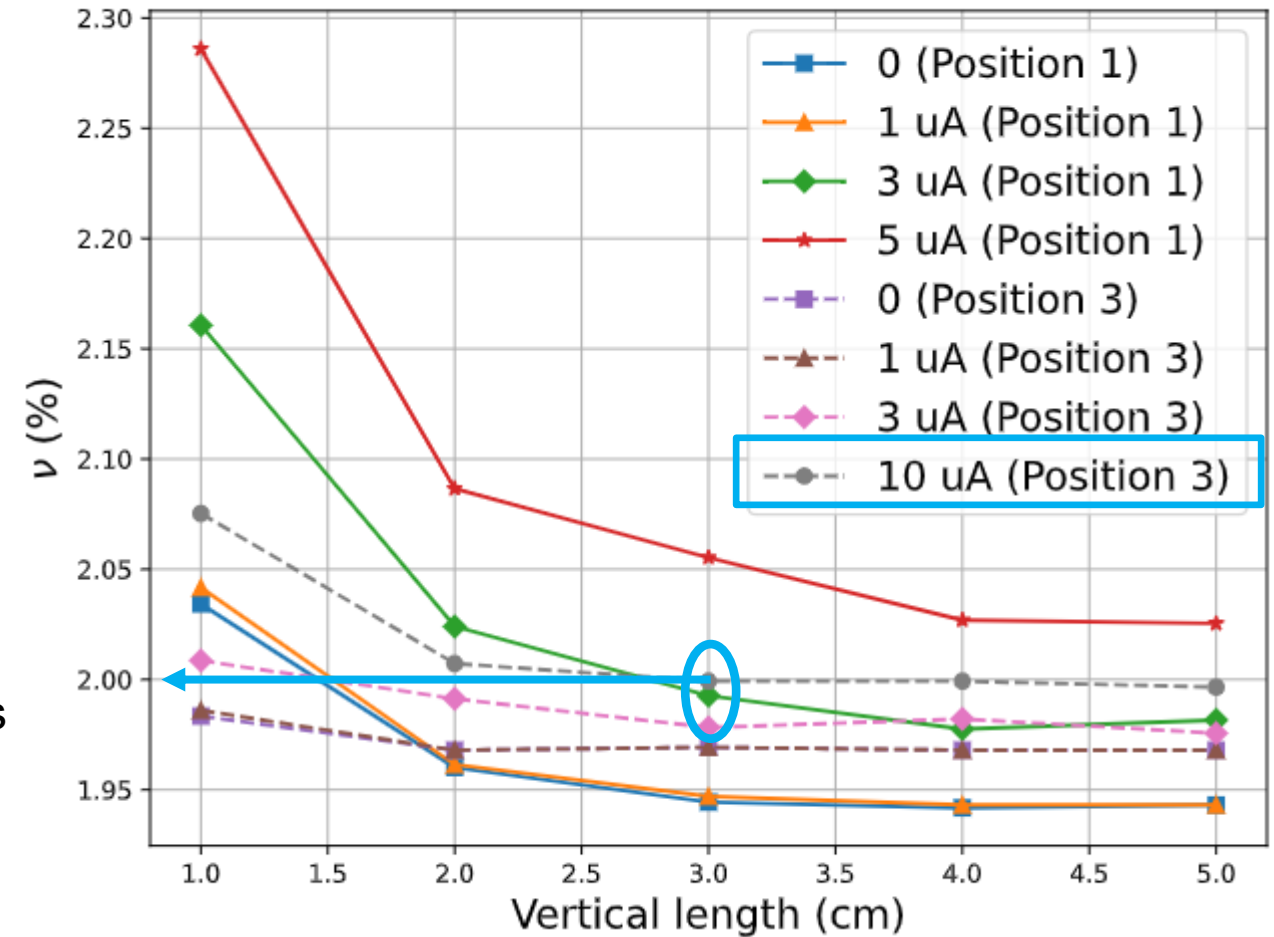
Detector Geometry & Layout Optimization

- Optimal choice: **Position 3**

- Reach 2% relative precision
- @ 1 cm (beam) × 3 cm (vertical)
- Single sided placed
- Lower noise requirement < 10 μ A
- Unaffected by beam-beam deflection and synchrotron

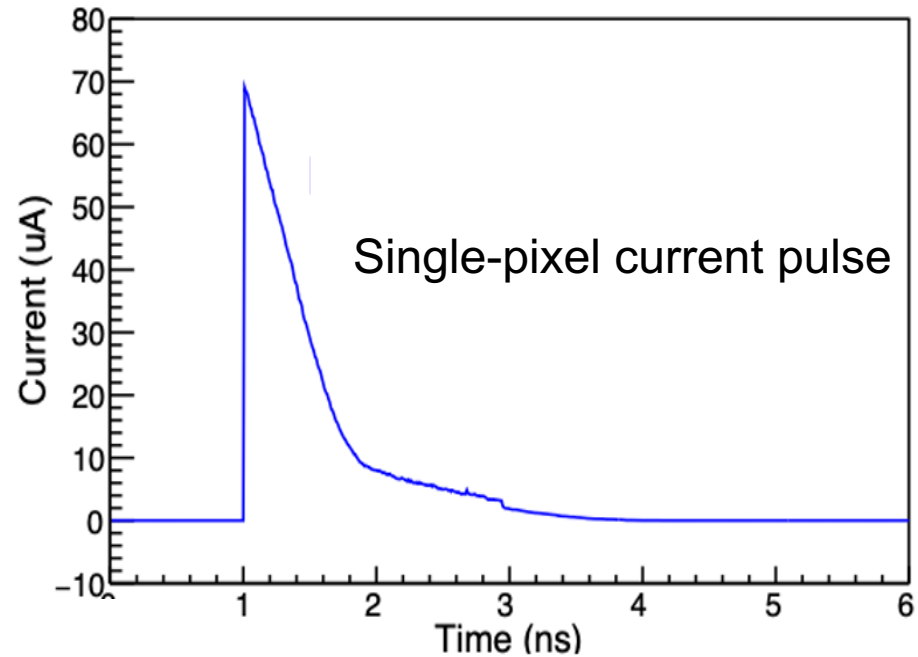
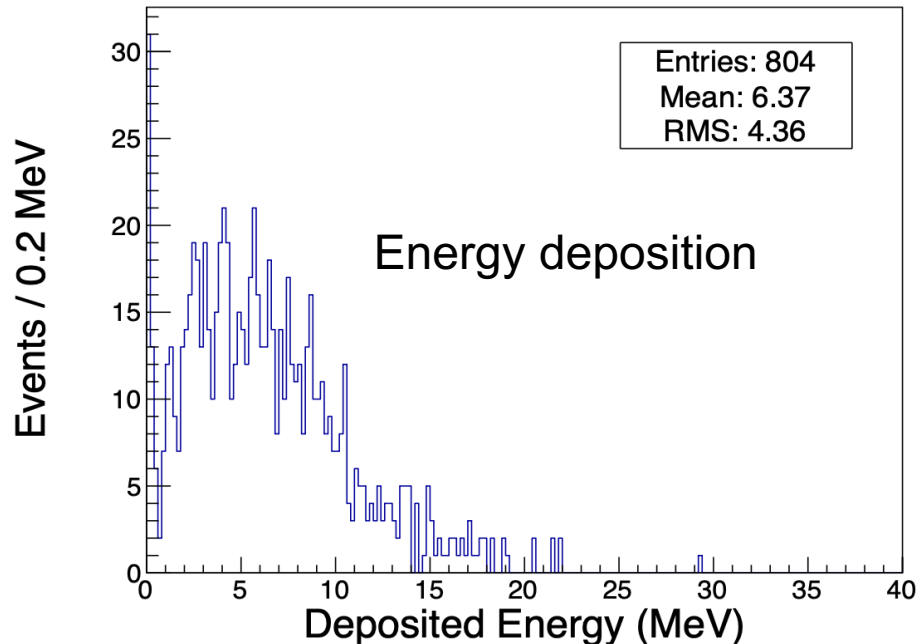
- Position 1: Also suggested by accelerator colleagues

- Captures differences between inner and outer sides



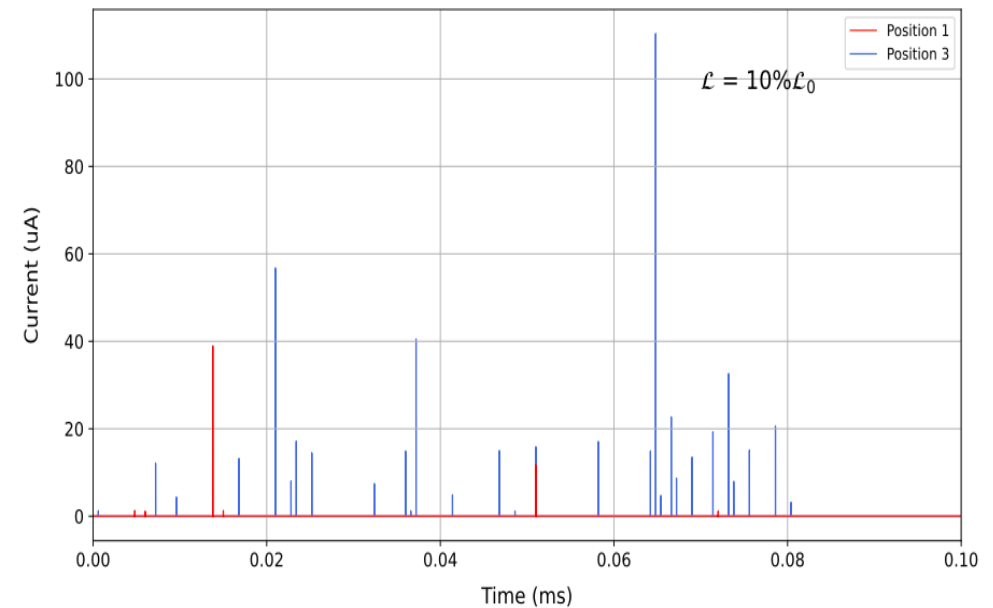
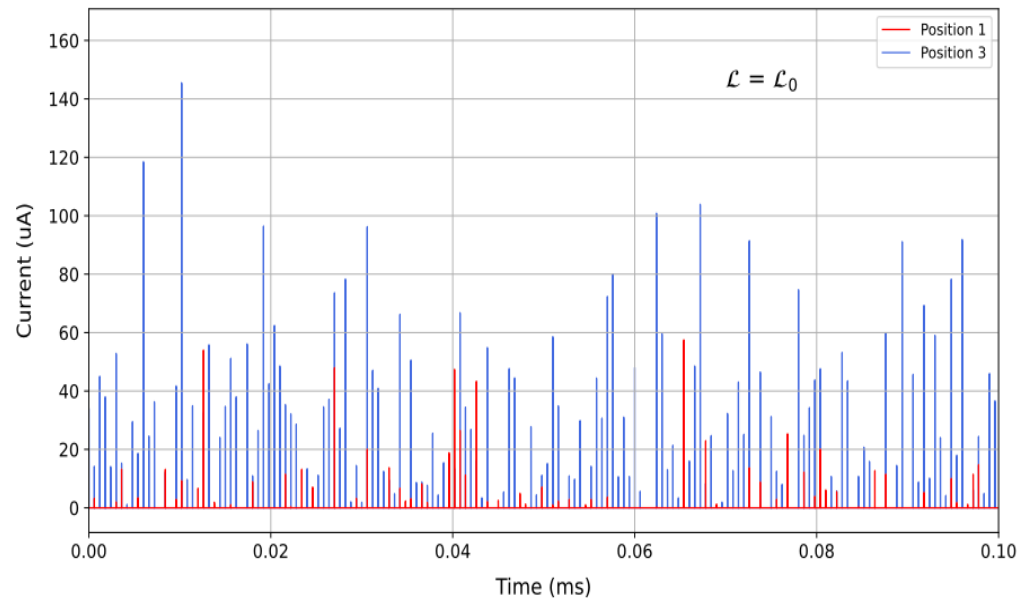
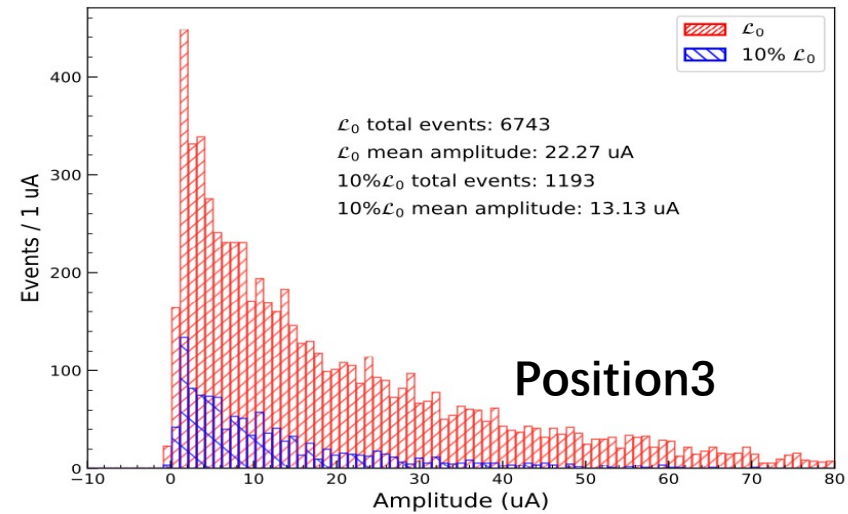
The Simulation to Estimate the Signal in the Detector

- Types of secondary particles detected
 - Photon-dominated (~87% of detected secondary particles)
 - Electrons < 8%
 - Others ~ 5%
- Detector performance at nominal luminosity (Position3)
 - Total Energy deposition: ~6 MeV per bunch crossing
 - Single-pixel current pulse: ~70 μA , ~3 ns full width



The Simulation to Estimate the Signal in the Detector

- Detector response to luminosity reduction
 - Simulation conditions: \mathcal{L}_0 (nominal) vs. $10\% \mathcal{L}_0$
- Observed effects at reduced luminosity
 - Fewer signal peaks (events decrease)
 - Lower amplitude per peak (weaker individual signals)



The Simulation to Estimate the Signal in the Detector

● Quantifying Detector Response vs. Luminosity

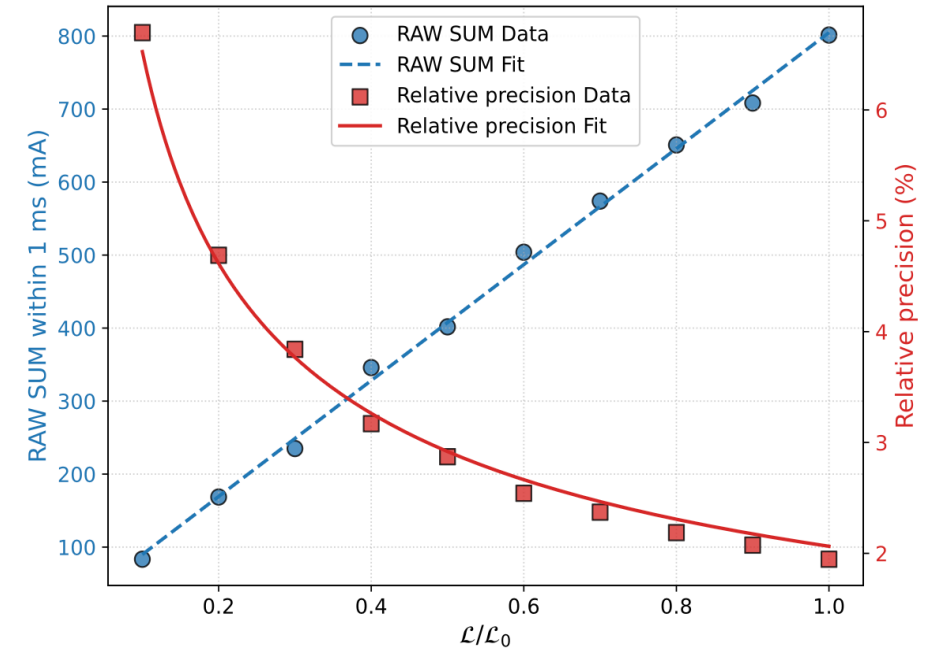
- RAW SUM: Sum of sampling points exceeding threshold within 1 ms

$$\text{RAW SUM} = \sum_{s \in \mathcal{S}} \sum_{p \in \mathcal{P}} i_j(s, p) \quad \text{at Position 3}$$

p: pixel number ; s: sampling point (10GHz, 1ms)

● Key findings

- Linear relationship: RAW SUM proportional to luminosity
- Precision: $\nu \propto 1/\sqrt{L}$
 - Nominal L_0 : 2%
 - 10% L_0 : ~7%
- SuperKEKB experience:
Even 7% precision feedback reduces beam offsets



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A simulation-based design of the CEPC fast luminosity monitor detector using 4H-SiC

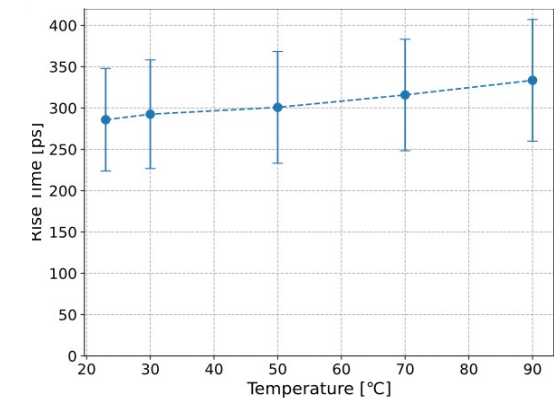
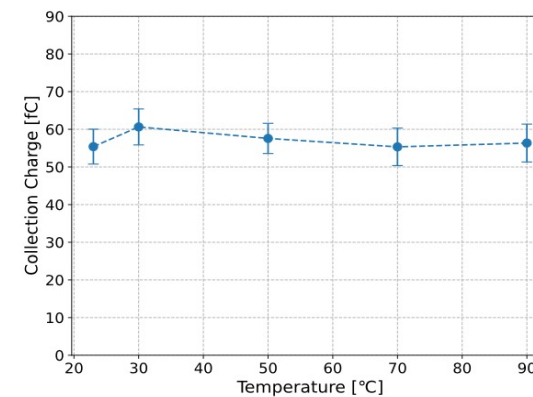
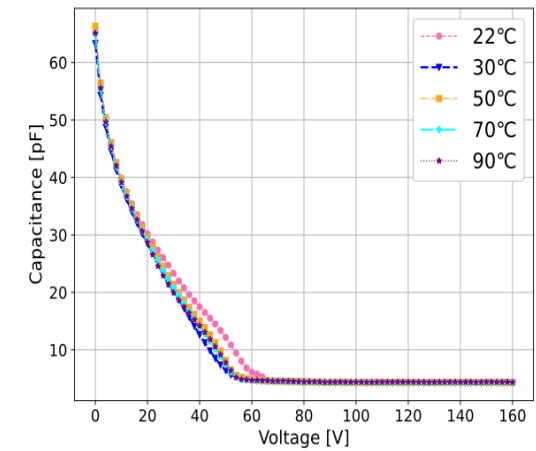
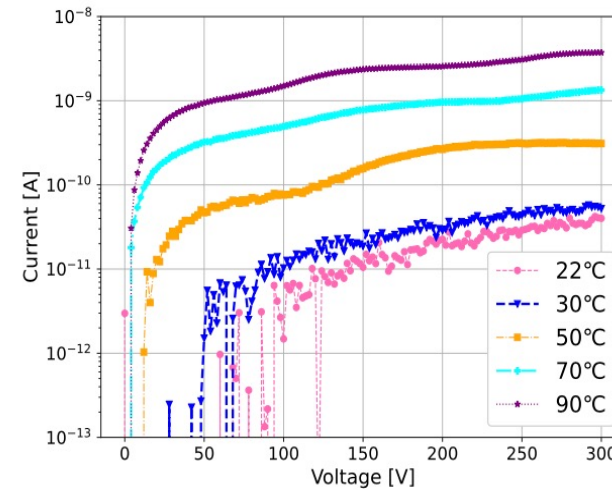
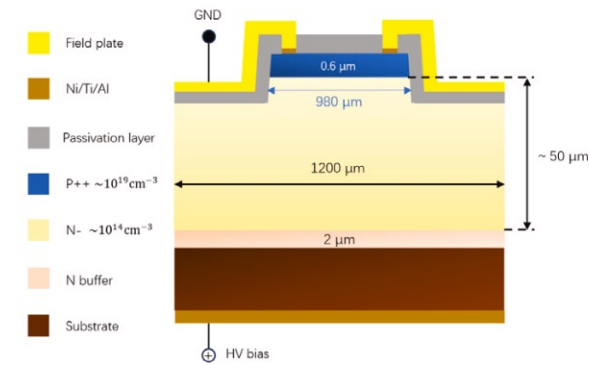
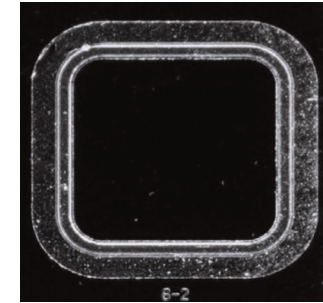
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4H-SiC detector development @ IHEP — SICAR1_PIN detector

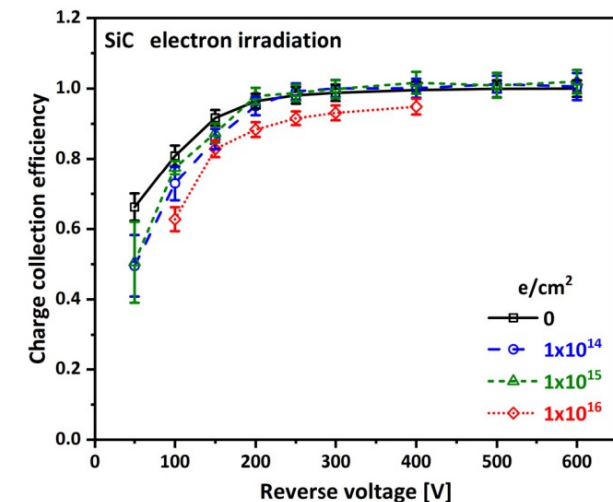
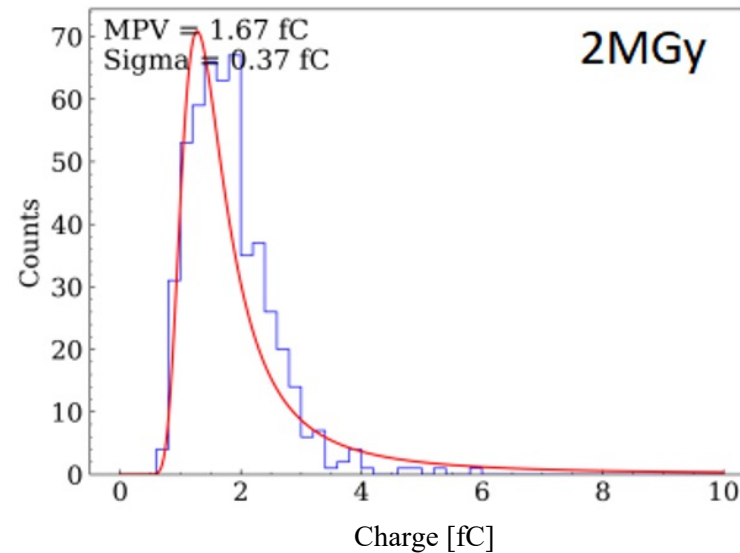
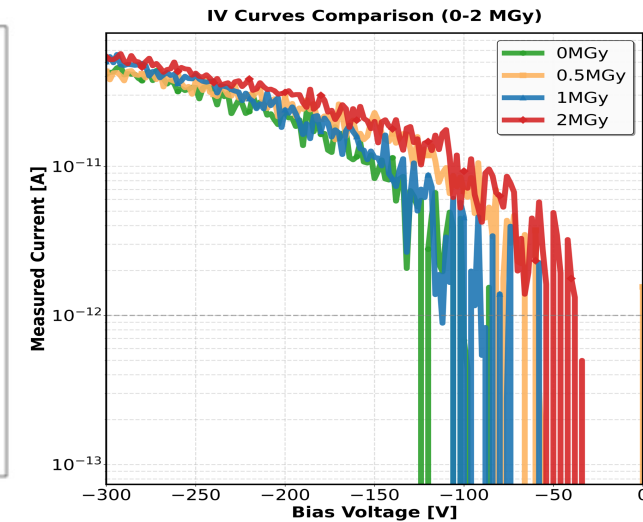
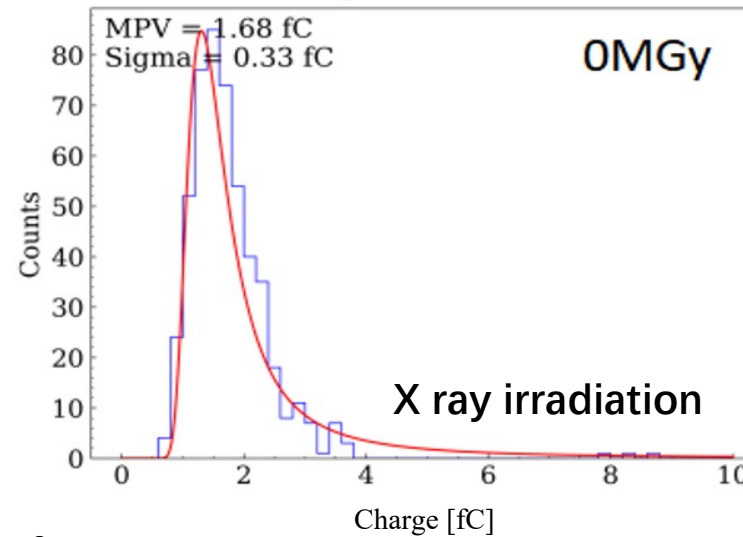
- 4H-SiC PIN detector structure (1.2 x1.2 mm²)
 - Full epitaxial growth including N- active region(50 μm) and P++ layer
 - Mesa termination + Field plate → reduced field crowding
 - Without high temperature ion implantation and high temperature post-annealing
- Excellent thermal stability
 - Ultra-low leakage current: ~50 pA at RT, ~10 nA at 90°C @300V
 - Capacitance temperature stability
 - Full depletion voltage ~ 76V
 - Full depletion capacitance: ~ 3.5 pF
 - CCE (α) : negligible variation
 - Ultra fast rise time: < 350ps @90°C



[<https://doi.org/10.1016/j.nima.2025.171178>]

4H-SiC detector development @ IHEP — SICAR1_PIN

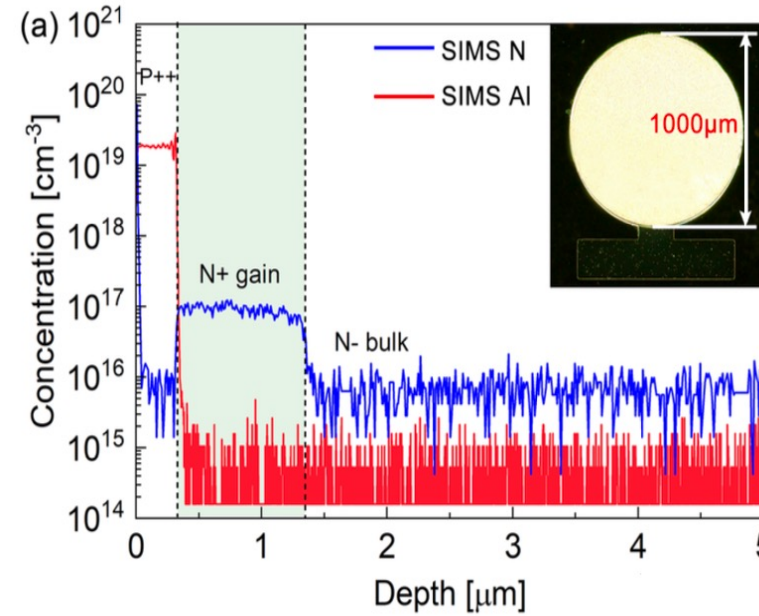
- FLM for CEPC—Secondary particles fraction
 - γ : 87% ; e^- : 8%
- X-ray radiation hardness up to 2MGy
 - Leakage current remains stable
 - CCE (β particle) — no degradation
- Electron radiation hardness up to 1×10^{16} e/cm²
 - CCE reduction in the range of 10% at 1×10^{16} e/cm²



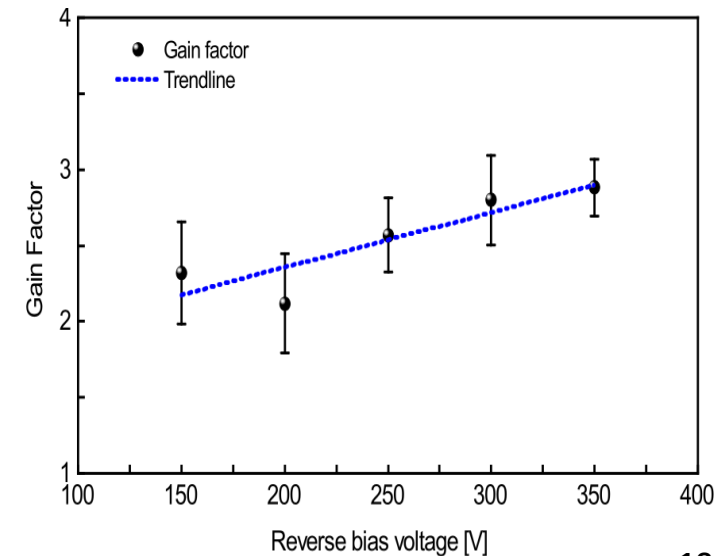
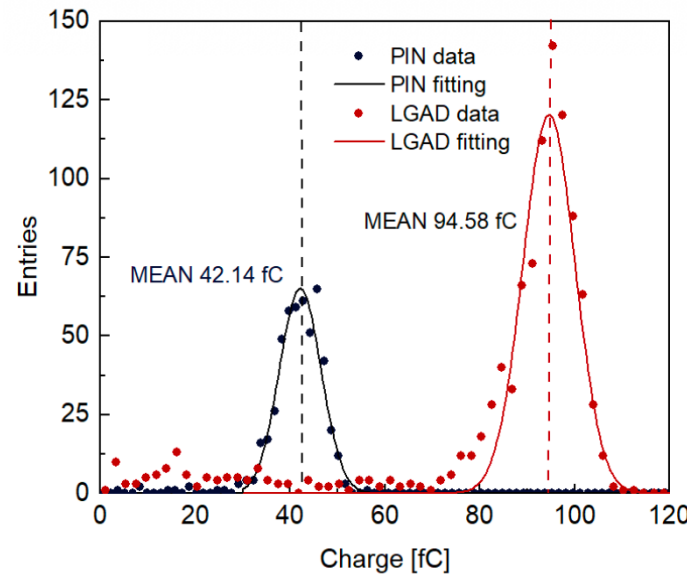
[DOI: [10.1109/TNS.2020.3029730](https://doi.org/10.1109/TNS.2020.3029730)]

4H-SiC detector development @ IHEP — SICAR1_LGAD

- 4H-SiC LGAD detector structure (1 x1 mm²)
 - Full epitaxial growth including N- active region(50 μ m)
 - N+ gain layer and P++ layer
 - Mesa termination
 - Without high temperature ion implantation and high temperature post-annealing



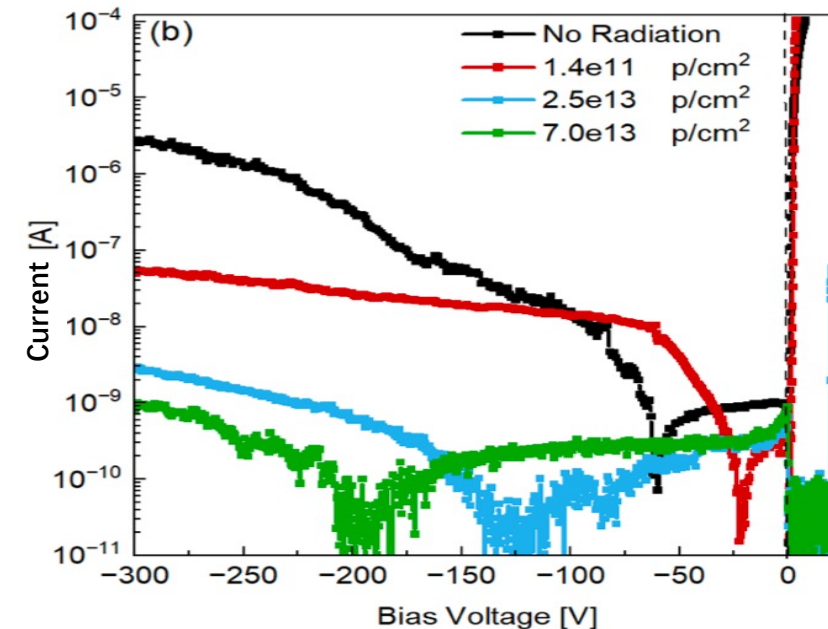
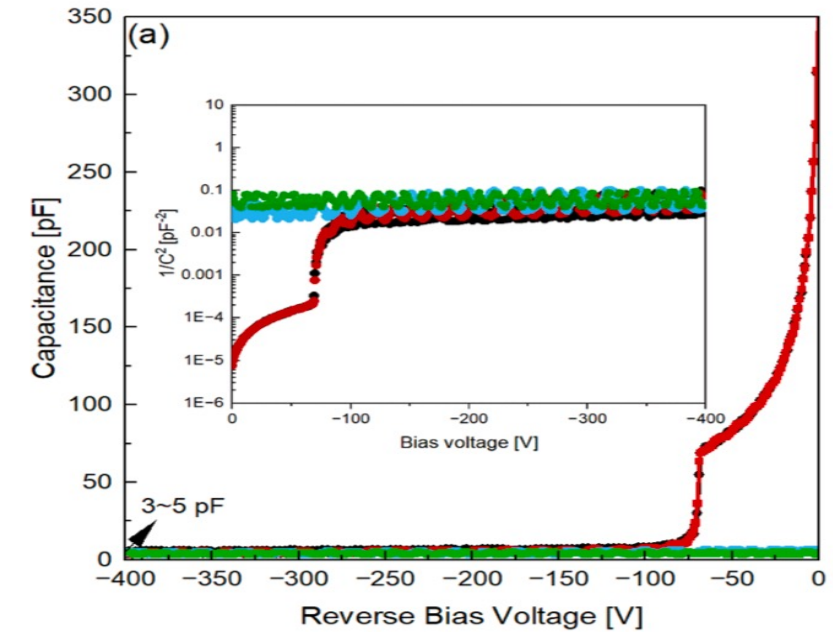
- Gain factor calibration with α source (²⁴¹Am)
 - Gain factor: 2-3 @ 300V



[DOI: [10.1109/TNS.2024.3471863](https://doi.org/10.1109/TNS.2024.3471863)]

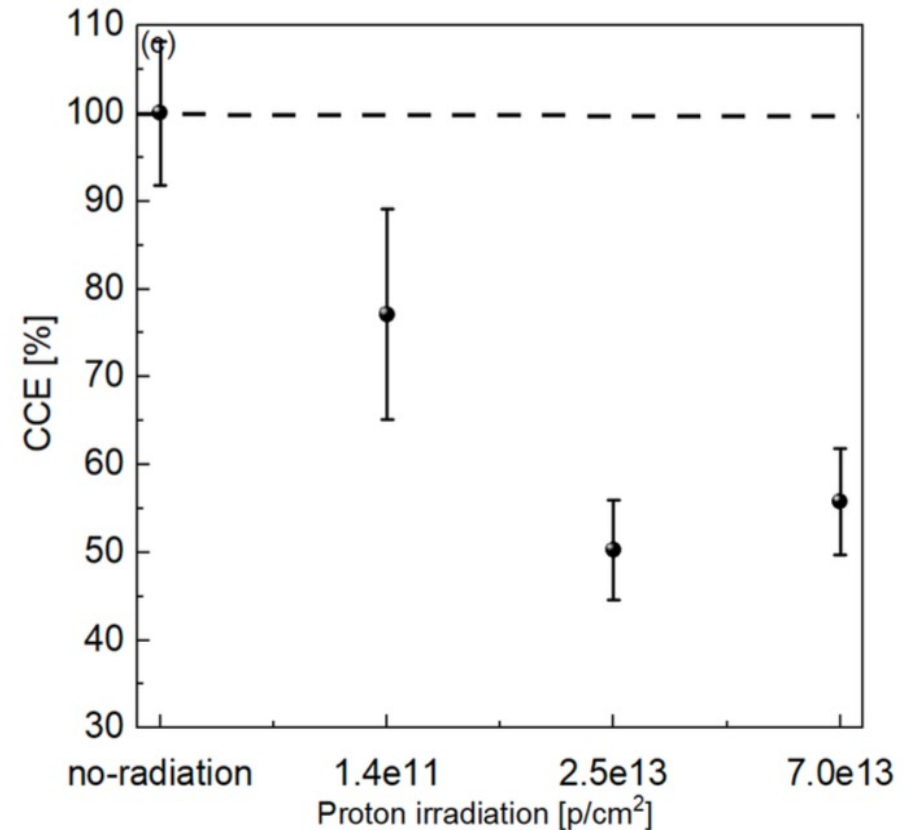
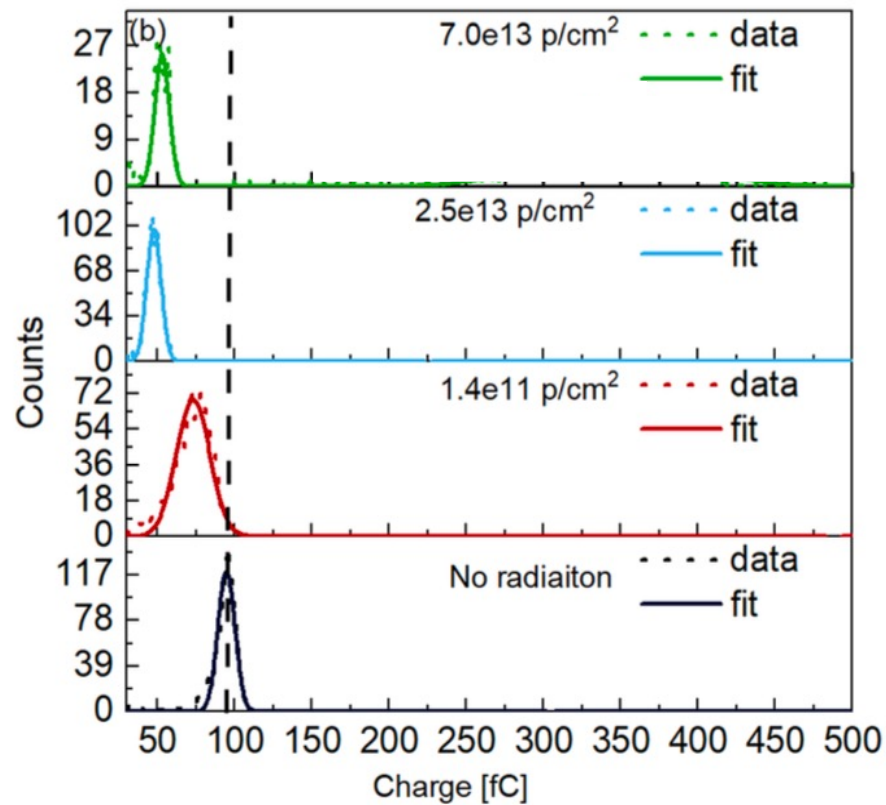
4H-SiC detector development @ IHEP — SICAR1_LGAD

- 4H-SiC LGAD proton irradiation hardness
 - Beam energy: **80 MeV** ;
 - Fluence: $1.4e11 p/cm^2$, $2.5e13 p/cm^2$, $7.0e13 p/cm^2$
 - CV
 - Parallel-plate capacitor-like ($2.5e13 p/cm^2 \sim 7e13 p/cm^2$)
 - Full depletion capacitance 3-5pF
 - IV
 - $> 1\mu A$ @300V (No irradiation);
 - 5 orders of magnitude higher than PIN
 - Decreases with increasing fluence; reaches nA level at high fluence



- Charge collection vs. irradiation fluence

- CCE degrades with irradiation fluence \uparrow
- $7e13p/cm^2 \rightarrow$ CCE drops to 57% \rightarrow Decay to a PIN device (Gain disappeared)



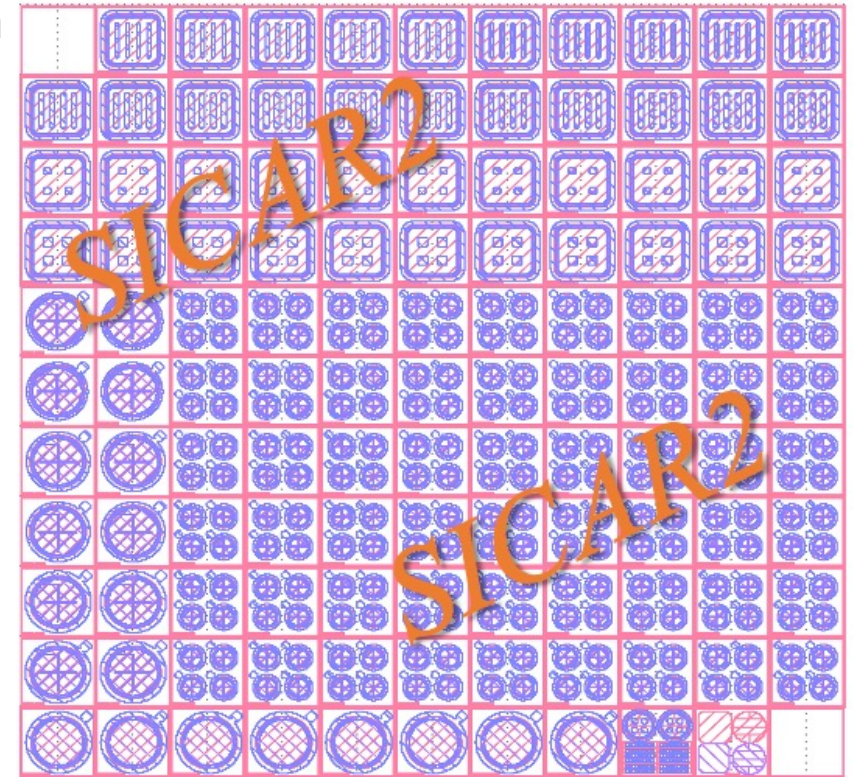
- 4H-SiC LGAD optimization_SiCAR2

- Adjust the concentration of gain layer → Objective: gain factor > 10 @ 300V

- **Transitioning SICAR2_LGAD to a 350nm MOSFET Process Platform**

- Replacing Contact with Stepper Lithography
- Single Reticle Field: 2.2cm × 2.2cm
- Die size: 1.5mm × 1.5mm & 0.6mm × 0.6mm
- Mesa termination with field plate to prevent the early breakdown

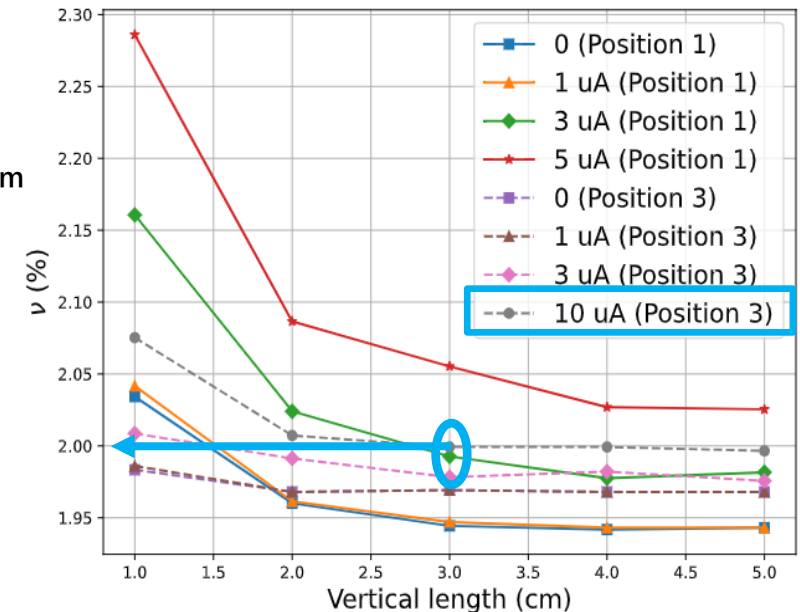
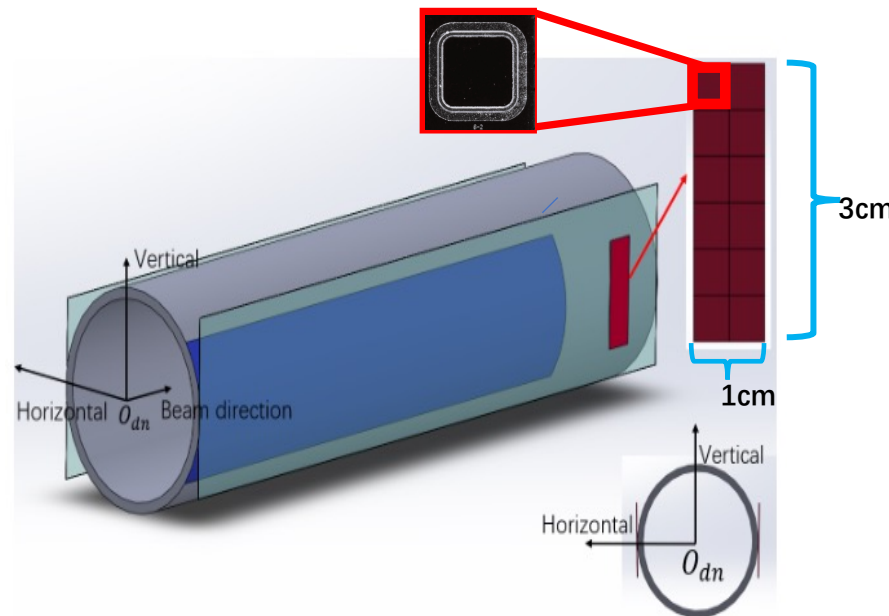
Undergoing.....



Summary

- Simulation determines the optimal position and geometry of the SiC-based Fast Luminosity Monitor for CEPC, meeting the 2% precision requirement.
- Simulated detector response shows a linear relationship with luminosity, proving its capability for real-time luminosity feedback.
- The optimized SiC LGAD designed, now in fabrication; delivery expected by summer.

Thanks!



- 4H-SiC LGAD optimization_SiCAR3

- High-temperature (500°C); high-energy implantation > 1 MV
- High-temperature annealing (1700°C) → Activate carriers and repair defects
- High fabrication complexity and high cost → MPW

Undergoing.....

